UNISONIC TECHNOLOGIES CO., LTD

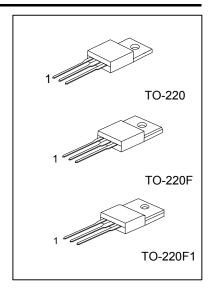
10N75 **Preliminary Power MOSFET**

10A, 750V N-CHANNEL POWER MOSFET

DESCRIPTION

The UTC 10N75 is a N-channel mode power MOSFET using UTC's advanced technology to provide costomers with planar stripe and DMOS technology. This technology specialized in allowing a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

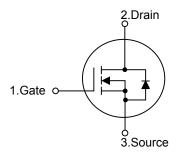
The UTC 10N75 is universally applied in high efficiency switch mode power supply, active power faction correction, electronic lamp based on half bridge topology.



FEATURES

- * R_{DS(on)}=1.3Ω @V_{GS}=10V
- * High switching speed
- * Improved dv/dt capability
- * 100% avalanche tested

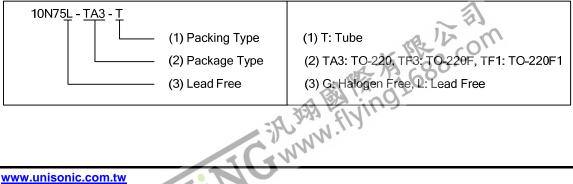
SYMBOL



ORDERING INFORMATION

Ordering Number		Doolsono	Pin Assignment			Doolsing	
Lead Free	Halogen Free	Package	1	2	3	Packing	
10N75L-TA3-T	10N75G-TA3-T	TO-220	G	D	S	Tube	
10N75L-TF3-T	10N75G-TF3-T	TO-220F	G	D	S	Tube	
10N75L-TF1-T	10N75G-TF1-T	TO-220F1	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain



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■ ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	750	٧
Gate-Source Voltage		V_{GSS}	±30	V
Drain Current	Continuous	I _D	10	Α
	Pulsed (Note 2)	I _{DM}	40	Α
Avalanche Current (Note 2)		I _{AR}	10	Α
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	920	mJ
	Repetitive (Note 2)	E _{AR}	24	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.0	V/ns
Power Dissipation	TO-220	7	156	W
	TO-220F/TO-220F1	P _D	50	W
Junction Temperature		TJ	+150	°C
Storage Temperature		T _{STG}	-55~+150	°C

- Note: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.
 - 2. Repetitive Rating: Pulse width limited by maximum junction temperature
 - 3. L=17.3mH, I_{AS} =10A, V_{DD} = 50V, R_{G} =25 Ω , Starting T_{J} =25 $^{\circ}$ C
 - 4. I_{SD}≤10A, di/dt≤200A/μs, V_{DD}≤BV_{DSS}, Starting T_J=25°C

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient	TO-220	0	62.5	°C/W
	TO-220F/TO-220F1	$\theta_{ m JA}$	62.5	°C/W
Junction to Case	TO-220	0	0.8	°C/W
	TO-220F/TO-220F1	$\theta_{ extsf{JC}}$	2.5	°C/W



ELECTRICAL CHARACTERISTICS (T_C=25°C, unless otherwise specified)

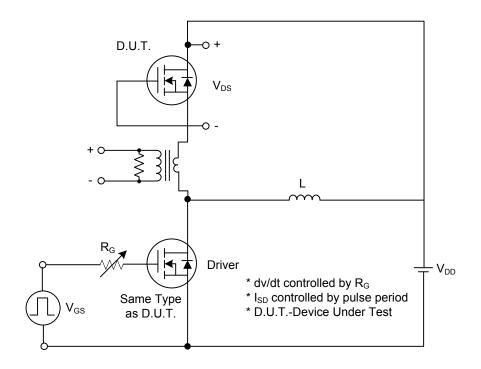
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250μA	750			V
Breakdown Voltage Temperature Coefficient	$\Delta BV_{DSS}/\Delta T_{J}$	I _D =250μA,Referenced to 25°C		0.98		V/°C
Drain Source Leakage Current	I _{DSS}	V _{DS} =750V, V _{GS} =0V			10	μΑ
Drain-Source Leakage Current		V _{DS} =640V, T _C =125°C			100	μΑ
Cata Source Leakage Current Forward	I _{GSS}	V_{DS} =0V , V_{GS} =30V			100	nA
Gate-Source Leakage Current Reverse		V_{DS} =0V , V_{GS} =-30V			-100	nA
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_D=250\mu A$	2.0		4.0	V
Drain-Source On-State Resistance	R _{DS(ON)}	V_{GS} =10V, I_D =5A		0.93	1.3	Ω
Forward Transconductance	g FS	V_{DS} =50V, I_D =5.0A (Note 1)		5.8		S
DYNAMIC PARAMETERS						
Input Capacitance	C _{ISS}			2150	2800	pF
Output Capacitance	Coss	V_{DS} =25V, V_{GS} =0V,f=1.0MHz		180	230	pF
Reverse Transfer Capacitance	C _{RSS}			15	20	pF
SWITCHING PARAMETERS						
Total Gate Charge	Q_G	\/ -600\/ \/ -10\/ -10A		45	58	nC
Gate-Source Charge	Q_GS	V _{DS} =600V, V _{GS} =10V, I _D =10A (Note 1, 2)		13.5		nC
Gate-Drain Charge	Q_{GD}	(Note 1, 2)		17		nC
Turn-ON Delay Time	t _{D(ON)}			50	110	ns
Turn-ON Rise Time	t _R	V_{DD} =350V, I_{D} =10A, R_{G} =25 Ω		130	270	ns
Turn-OFF Delay Time	t _{D(OFF)}	V _{DS} =10V (Note 1, 2)		90	190	ns
Turn-OFF Fall Time	t _F			80	170	ns
SOURCE- DRAIN DIODE RATINGS AND C	HARACTERI	STICS				
Maximum Body-Diode Continuous Current	Is				10.0	Α
Maximum Body-Diode Pulsed Current	I _{SM}				40.0	Α
Drain-Source Diode Forward Voltage	V_{SD}	I _S =10.0A, V _{GS} =0V			1.4	V
Body Diode Reverse Recovery Time	t _{rr}	V _{GS} =0V, I _S =10.0A,		730		ns
Body Diode Reverse Recovery Charge	Q_{RR}	dI _F /dt=100A/μs (Note 1)		10.9		μC

Note: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%

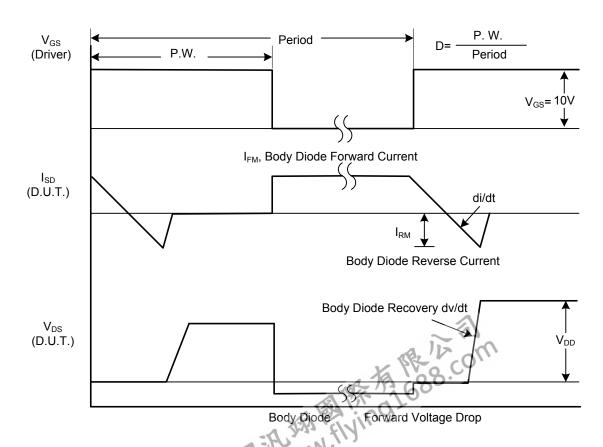
2. Essentially independent of operating temperature



TEST CIRCUITS AND WAVEFORMS



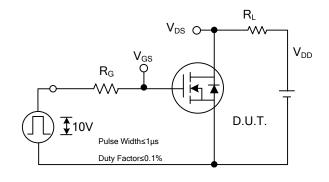
Peak Diode Recovery dv/dt Test Circuit

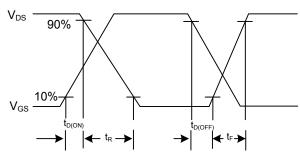


Peak Diode Recovery dv/dt Waveforms

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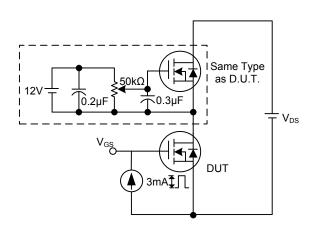
TEST CIRCUITS AND WAVEFORMS (Cont.)

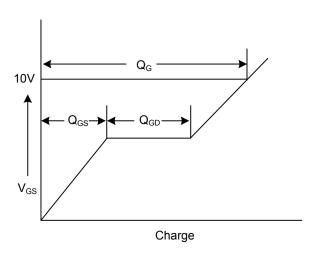




Switching Test Circuit

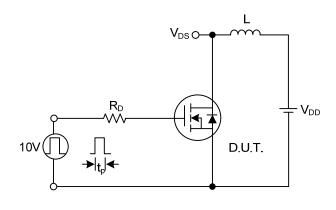
Switching Waveforms

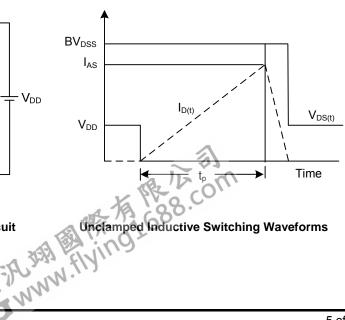




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

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